

IDC05S60C

2nd generation thinQ!TM SiC Schottky Diode

FEATURES:

Applications:

material - • SMPS, PFC, snubber



- Revolutionary semiconductor material -Silicon Carbide
- Switching behavior benchmark
- No reverse recovery
- No temperature influence on the switching behavior
- No forward recovery
- High surge current capability

Chip Type	V _{BR}	I _F	Die Size	Package
IDC05S60C	600V	5A	1.45 x 1.162 mm ²	sawn on foil

MECHANICAL PARAMETER:

Raster size	1.45x 1.162	— mm			
Anode pad size	1.213 x 0.925				
Area total / active	1.68 / 1.22	mm ²			
Thickness	355	μm			
Wafer size	75	mm			
Flat position	0	deg			
Max. possible chips per wafer	2182 pcs				
Passivation frontside	Photoimide				
Anode metalization	3200 nm Al				
Cathode metalization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	Electrically conductive glue or solder				
Wire bond	AI, ≤ 350μm				
Reject Ink Dot Size	Ø ≥ 0.3 mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				

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IDC05S60C

Maximum Ratings

Parameter	Symbol	Condition	Value	Unit	
Repetitive peak reverse voltage	V _{RRM}		600		
DC blocking voltage	V _{DC}		600	V	
Continuous forward current limited by $T_{j\text{max}}$	/ _F		5		
Surge non repetitive forward current sine halfwave	I _{F,SM}	$T_C = 25^{\circ}C, t_P = 10 ms$	42	A	
Repetitive peak forward current limited by T _{jmax}	I _{F,RM}	$T_C = 100 ^{\circ}C, \ T_j = 150 ^{\circ}C, \ D = 0.1$	21		
Non-repetitive peak forward current	I _{F,max}	$T_C = 25^{\circ}C, tp = 10\mu s$	180	1	
Operating junction and storage temperature	T_{j} , T_{stg}		-55+175	°C	

Static Electrical Characteristics (tested on chip), T_j =25 °C, unless otherwise specified

Parameter	Symbol	Cond	Value			Unit	
i diameter	Gymbol	Conditions		min.	Тур.	max.	
Reverse current	I _R	V _R =600V	<i>T_j</i> =25 ° <i>C</i>		0.6	70	μA
Diode forward voltage	V _F	I _F =5A	<i>T_j</i> =25°C		1.5	1.7	V

Dynamic Electrical Characteristics, at $T_i = 25$ °C, unless otherwise specified, tested at component

Parameter	Symbol	Conditions		Value			Unit
	Symbol			min.	Тур.	max.	Unit
Total capacitive charge	Q _C	$I_F <= I_{F,max}$ di/dt = 200 A/ms	$T_j = 150 \ ^\circ C$		12		nC
Switching time ¹⁾	t _c	V _R =400V	$T_j = 150 \ ^\circ C$			<10	ns
Total capacitance	с	f=1MHz	$V_R = 1 V$		240		
			V _R =300V		30		pF
			V _R =600V		30		

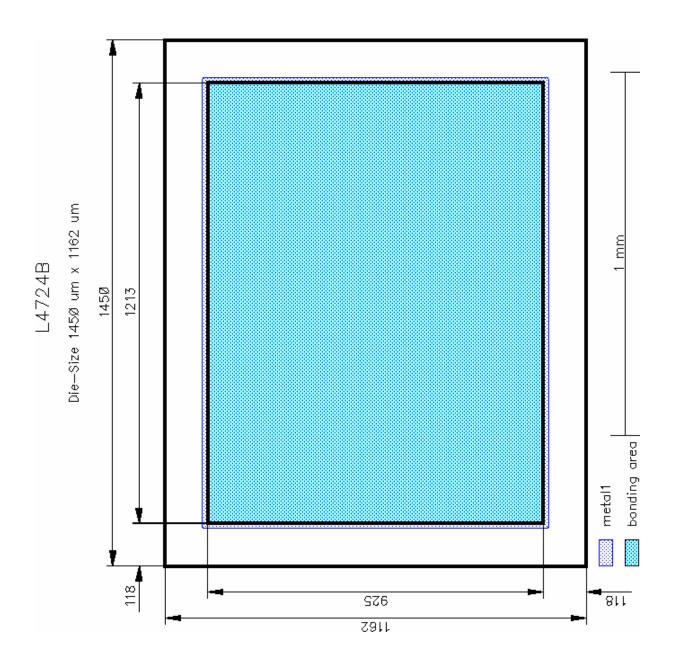
 $^{1)}$ t_c is the time constant for the capacitive displacement current waveform (independent from T_j, I_{LOAD} and di/dt), different from t_{rr} which is dependent on T_j, I_{LOAD} and di/dt. No reverse recovery time constant t_{rr} due to absence of minority carrier injection

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CHIP DRAWING:



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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

INFINEON TECHNOLOGIES

IDT05S60C

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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